

**SN54LS682, SN54LS684, SN54LS685, SN54LS687, SN54LS688,
SN74LS682, SN74LS684 THRU SN74LS688
8-BIT MAGNITUDE/IDENTITY COMPARATORS**

SDLS008

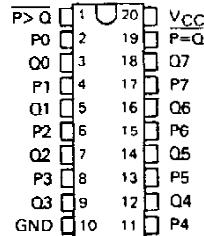
D2617, JANUARY 1981 - REVISED MARCH 1988

- Compares Two 8-Bit Words
- Choice of Totem-Pole or Open-Collector Outputs
- Hysteresis at P and Q Inputs
- 'LS682 has 20-kΩ Pullup Resistors on the Q Inputs
- SN74LS686 and 'LS687 . . . JT and NT 24-Pin, 300-Mil Packages

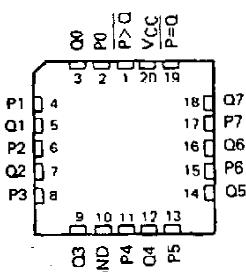
TYPE	P = Q	P > Q	OUTPUT ENABLE	OUTPUT CONFIGURATION	20-kΩ PULLUP
'LS682	yes	yes	no	totem-pole	yes
'LS684	yes	yes	no	totem-pole	no
'LS685	yes	yes	no	open-collector	no
SN74LS686	yes	yes	yes	totem-pole	no
'LS687	yes	yes	yes	open-collector	no
'LS688	yes	no	yes	totem-pole	no

SN54LS682, SN54LS684, SN54LS685 . . . J PACKAGE
SN74LS682, SN74LS684, SN74LS685 . . . DW OR N PACKAGE

(TOP VIEW)

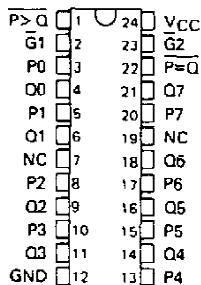


SN54LS682, SN54LS684, SN54LS685 . . . FK PACKAGE
(TOP VIEW)

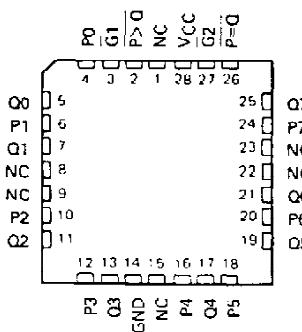


SN54LS687 . . . JT PACKAGE
SN74LS686, SN74LS687 . . . DW OR NT PACKAGE

(TOP VIEW)



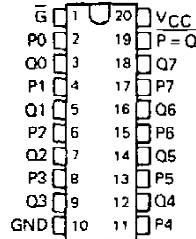
SN54LS687 . . . FK PACKAGE
(TOP VIEW)



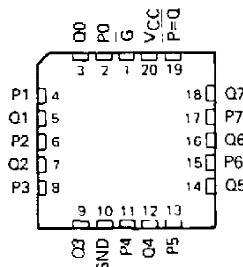
NC - No internal connection

SN54LS688 . . . J PACKAGE
SN74LS688 . . . DW OR N PACKAGE

(TOP VIEW)



SN54LS688 . . . FK PACKAGE
(TOP VIEW)



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**SN54LS682, SN54LS684, SN54LS685, SN54LS687, SN54LS688
SN74LS682, SN74LS684 THRU SN74LS688
8-BIT MAGNITUDE/IDENTITY COMPARATORS**

description

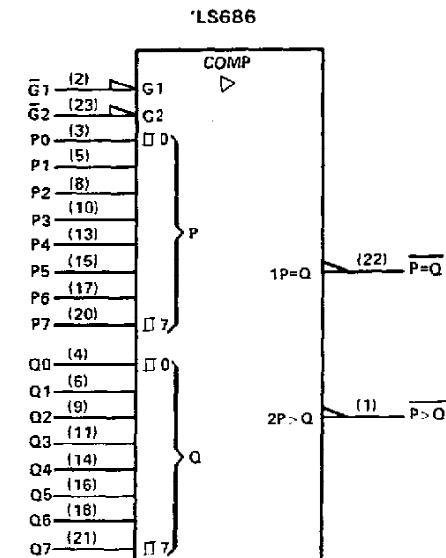
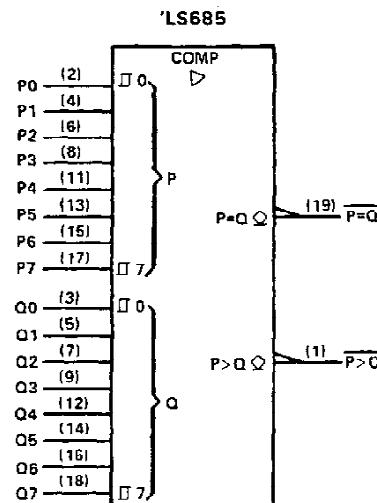
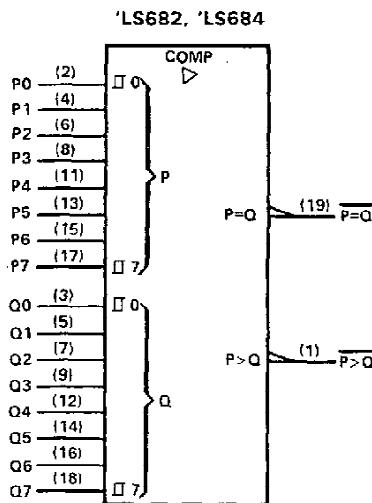
These magnitude comparators perform comparisons of two eight-bit binary or BCD words. All types provide $P = Q$ outputs and all except 'LS688 provide $P > Q$ outputs as well. The 'LS682, 'LS684, 'LS686, and 'LS688 have totem-pole outputs, while the 'LS685 and 'LS687 have open-collector outputs. The 'LS682 features 20-k Ω pullup termination resistors on the Q inputs for analog or switch data.

FUNCTION TABLE

DATA	INPUTS		OUTPUTS	
	\bar{G}	\bar{G}_1	\bar{G}_2	$\bar{P} = \bar{Q}$
$P = Q$	L	X	X	L
$P > Q$	X	L	X	L
$P < Q$	X	X	X	H
$P = Q$	H	X	X	H
$P > Q$	X	H	H	H
X	H	H	H	H

- NOTES: 1. The last three lines of the function table applies only to the devices having enable inputs, i.e., 'LS686 thru 'LS688.
 2. The $\bar{P} < \bar{Q}$ function can be generated by applying the $\bar{P} = \bar{Q}$ and $\bar{P} > \bar{Q}$ outputs to a 2-input NAND gate.
 3. For 'LS686 and 'LS687, \bar{G}_1 enables $\bar{P} = \bar{Q}$ and \bar{G}_2 enables $\bar{P} > \bar{Q}$.

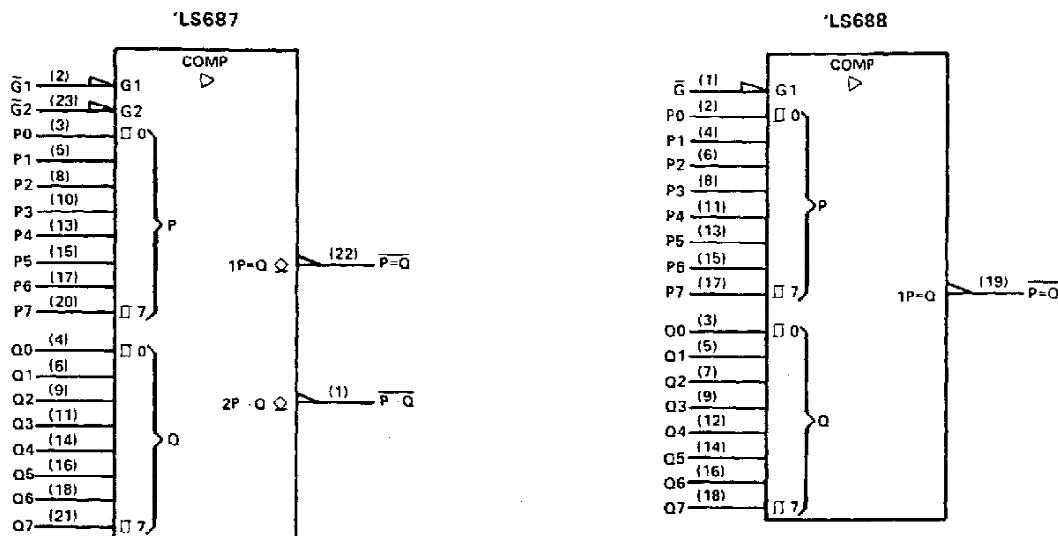
logic symbols†



†These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for DW, J, JT, N, and NT packages.

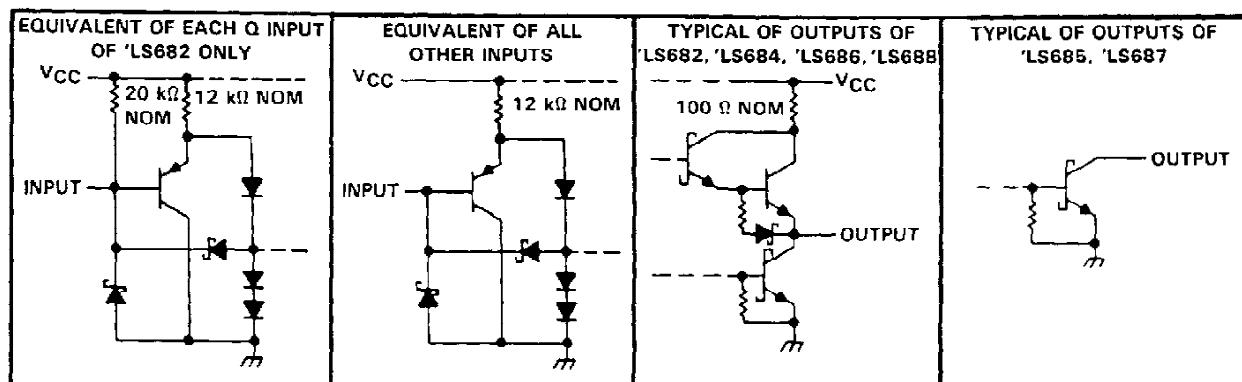
**SN54LS682, SN54LS684, SN54LS685, SN54LS687, SN54LS688,
SN74LS682, SN74LS684 THRU SN74LS688
8-BIT MAGNITUDE/IDENTITY COMPARATORS**

logic symbols[†] (continued)



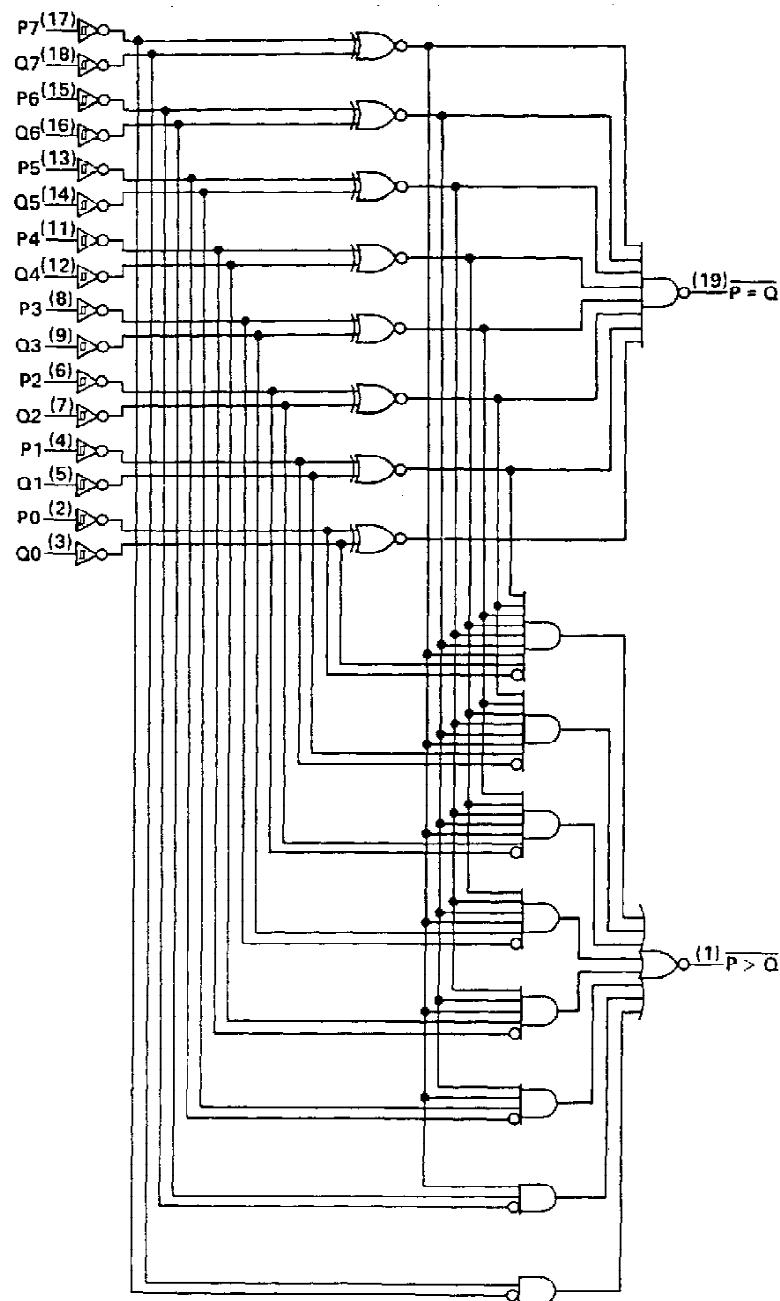
[†]These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for DW, J, JT, N, and NT packages.

schematics of inputs and outputs



**SN54LS682, SN54LS684, SN54LS685
SN74LS682, SN74LS684, SN74LS685
8-BIT MAGNITUDE/IDENTITY COMPARATORS**

'LS682, 'LS684, 'LS685 logic diagram (positive logic)



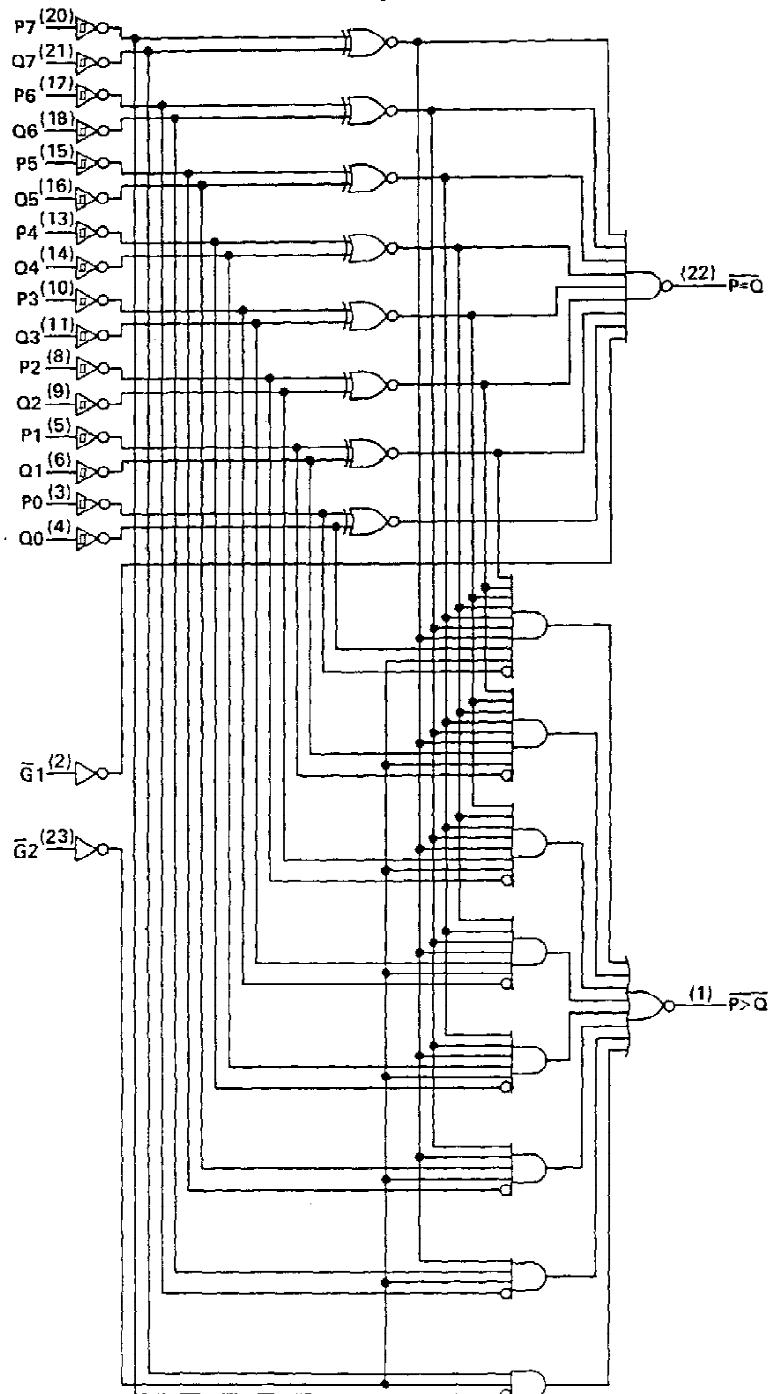
Pin numbers shown are for DW, J, and N packages.

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SN54LS687
 SN74LS686, SN74LS687
 8-BIT MAGNITUDE/IDENTITY COMPARATORS

'LS686, 'LS687 logic diagram (positive logic)



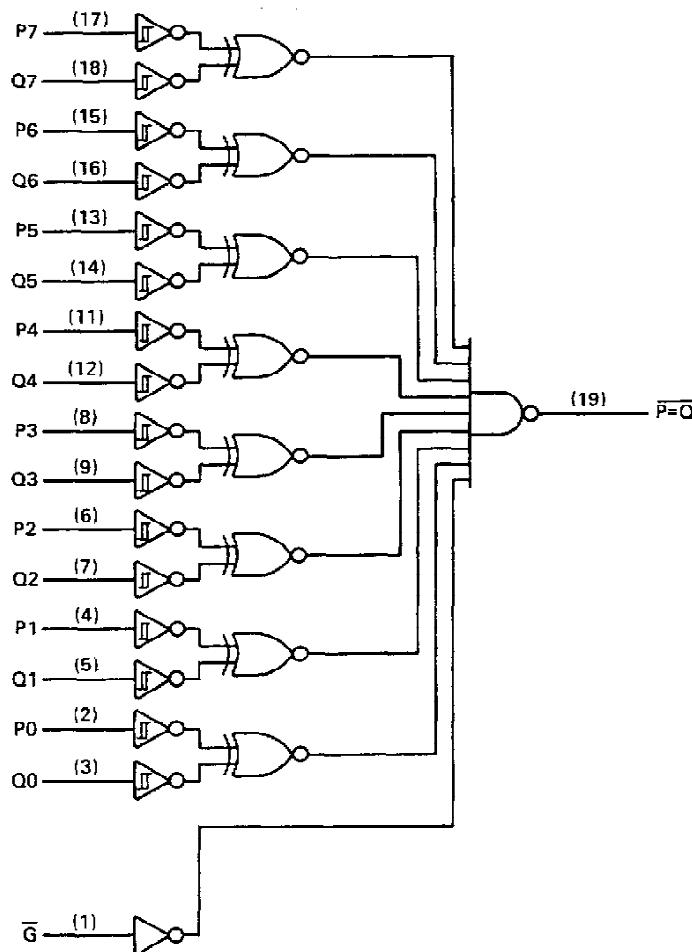
Pin numbers shown are for DW, JT, and NT packages.

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**SN54LS682, SN54LS684, SN54LS685, SN54LS687, SN54LS688
 SN74LS682, SN74LS684 THRU SN74LS688
 8-BIT IDENTITY COMPARATORS**

'LS688 logic diagram (positive logic)



Pin numbers shown are for DW, J, and N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)	7 V
Input voltage: Q inputs of 'LS682	5.5 V
All other inputs	7 V
Off-state output voltage: 'LS685, 'LS687	7 V
Operating free-air temperature range: SN54LS682, SN54LS684, SN54LS685, SN54LS687, SN54LS688	-55°C to 125°C
SN74LS682, SN74LS684 thru SN74LS688	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

**SN54LS682, SN54LS684, SN54LS688
SN74LS682, SN74LS684, SN74LS686, SN74LS688
8-BIT MAGNITUDE/IDENTITY COMPARATORS WITH TOTEM-POLE OUTPUTS**

recommended operating conditions

	SN54LS'			SN74LS'			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.85	5	5.25	V
High-level output current, I_{OH}			-400			-400	μA
Low-level output current, I_{OL}			12			24	mA
Operating free-air temperature, T_A	-55		125	0		70	$^{\circ}C$

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]	SN54LS'			SN74LS'			UNIT
		MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	
V_{IH}	High-level input voltage			2		2		V
V_{IL}	Low-level input voltage				0.7		0.8	V
$V_T+ - V_T-$	Hysteresis				0.4		0.4	V
V_{IK}	P or Q inputs	$V_{CC} = \text{MIN}$			-1.5		-1.5	V
V_{OH}	High-level output voltage	$V_{CC} = \text{MIN}$, $V_{IL} = V_{IL\text{max}}$, $I_{OH} = -400 \mu A$	0.4		2.5		2.7	V
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2 V$,	0.25	0.4	0.25	0.4		V
		$V_{IL} = V_{IL\text{max}}$, $I_{OL} = 12 \text{ mA}$				0.35	0.5	
I_I	Input current at maximum input voltage	$V_{CC} = \text{MAX}$, $V_I = 5.5 \text{ V}$			0.1		0.1	mA
	All other inputs	$V_{CC} = \text{MAX}$, $V_I = 7 \text{ V}$						
I_{IH}	High-level input current	$V_{CC} = \text{MAX}$, $V_I = 2.7 \text{ V}$		20		20		μA
I_{IL}	Q inputs, 'LS682	$V_{CC} = \text{MAX}$, $V_I = 0.4 \text{ V}$		-0.4		-0.4		mA
	All other inputs			-0.2		-0.2		
$I_{OS}^§$	Short-circuit output current	$V_{CC} = \text{MAX}$, $V_O = 0$	-20	-100	-20	-100		mA
I_{CC}	Supply current	$V_{CC} = \text{MAX}$, See Note 1	42	70	42	70		mA
			40	65	40	65		
			44	75	44	75		
			40	65	40	65		

[†] For conditions shown as MIN or MAX, use the appropriate values specified under recommended operating conditions.

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§] Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

NOTE 1: I_{CC} is measured with any \bar{G} inputs grounded, all other inputs at 4.5 V, and all outputs open.

**SN54LS682, SN54LS684, SN54LS688
 SN74LS682, SN74LS684, SN74LS686, SN74LS688
 8-BIT MAGNITUDE/IDENTITY COMPARATORS WITH TOTEM-POLE OUTPUTS**

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER ^T	FROM (INPUTS)	TO (OUTPUT)	TEST CONDITIONS	'LS682			'LS684			'LS686			'LS688			UNIT
				MIN	TYP	MAX										
t _{PLH}	P	$\bar{P} = \bar{Q}$	$R_L = 667 \Omega$, $C_L = 45 \text{ pF}$, All other inputs low, See Note 2	13	25		15	25		13	25		12	18	ns	
t _{PHL}				15	25		17	25		20	30		17	23		
t _{PLH}	Q	$\bar{P} = \bar{Q}$		14	25		16	25		13	25		12	18	ns	
t _{PHL}				15	25		15	25		21	30		17	23		
t _{PLH}	\bar{G}, \bar{G}_1	$\bar{P} = \bar{Q}$								11	20		12	18	ns	
t _{PHL}										19	30		13	20		
t _{PLH}	P	$\bar{P} > Q$		20	30		22	30		19	30				ns	
t _{PHL}				15	30		17	30		15	30					
t _{PLH}	Q	$\bar{P} > Q$		21	30		24	30		18	30				ns	
t _{PHL}				19	30		20	30		19	30					
t _{PLH}	\bar{G}_2	$\bar{P} > Q$								21	30				ns	
t _{PHL}										16	25					

^Tt_{PLH} = propagation delay time, low-to-high-level outputs; t_{PHL} = propagation delay time, high-to-low-level output.
 NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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**SN54LS685, SN54LS687
SN74LS685, SN74LS687, SN74LS688
8-BIT MAGNITUDE/IDENTITY COMPARATORS WITH TOTEM-POLE OUTPUTS**

recommended operating conditions

	SN54LS'			SN74LS'			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.85	5	5.25	V
High-level output current, I_{OH}			5.5			5.5	V
Low-level output current, I_{OL}			12			24	mA
Operating free-air temperature, T_A	-55	125	0	0	70	70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]	SN54LS'			SN74LS'			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
V_{IH}	High-level input voltage			2		2		V
V_{IL}	Low-level input voltage			0.7		0.8		V
$V_{T+} - V_{T-}$ Hysteresis	P or Q inputs	$V_{CC} = \text{MIN}$		0.4		0.4		V
V_{IK}	Input clamp voltage	$V_{CC} = \text{MIN}$, $I_I = -18 \text{ mA}$		-1.5		-1.5		V
I_{OH}	High-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $V_{IL} = V_{IL\text{max}}$, $V_{OH} = 5.5 \text{ V}$		250		100		μA
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$,	$I_{OL} = 12 \text{ mA}$	0.25	0.4	0.25	0.4	V
		$V_{IL} = V_{IL\text{max}}$	$I_{OL} = 24 \text{ mA}$			0.35	0.5	
I_I		$V_{CC} = \text{MAX}$, $V_I = 7 \text{ V}$		0.1		0.1		mA
I_{IH}	High-level input current	$V_{CC} = \text{MAX}$, $V_I = 2.7 \text{ V}$		20		20		μA
I_{IL}	Low-level input current	$V_{CC} = \text{MAX}$, $V_I = 0.4 \text{ V}$		-0.2		-0.2		mA
I_{CC}	Supply current	'LS685		40	65	40	65	mA
		'LS687	$V_{CC} = \text{MAX}$, See Note 1	44	75	44	75	

[†]For conditions shown as MIN or MAX, use the appropriate values specified under recommended operating conditions.

[‡]All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

NOTE 1: I_{CC} is measured with any \bar{G} inputs grounded, all other inputs at 4.5 V, and all outputs open.

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SN54LS685, SN54LS687

SN74LS685, SN74LS687

8-BIT MAGNITUDE/IDENTITY COMPARATORS WITH OPEN-COLLECTOR OUTPUTS

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS685			'LS687			UNIT	
				MIN	TYP	MAX	MIN	TYP	MAX		
t_{PLH}	P	$P = Q$	$R_L = 667 \Omega$, $C_L = 45 \text{ pF}$, All other inputs low, See Note 2	30	45		24	35		ns	
t_{PHL}				19	35		20	30			
t_{PLH}		$P = Q$		24	45		24	35			
t_{PHL}				23	35		20	30			
t_{PLH}		\bar{G}, \bar{G}_1					21	35			
t_{PHL}							1B	30			
t_{PLH}		$P > Q$		32	45		24	35			
t_{PHL}				16	35		16	30			
t_{PLH}		Q		30	45		24	35		ns	
t_{PHL}				20	35		16	30			
t_{PLH}	\bar{G}_2	$P > Q$					24	35		ns	
t_{PHL}							15	30			

[†] t_{PLH} = propagation delay time, low-to-high-level outputs; t_{PHL} = propagation delay time, high-to-low-level output.

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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